Sear	rch N	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/762,571	ABDEL-HAFEZ ET AL.
Examiner	Art Unit
R. Stephen Dildine	2133

SEARCHED				
Class	Subclass	Date	Examiner	
714	727 & 729	11/15/2005	RSD	
	-			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		,		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
714/726 (U.S. documents, see Search History printout)	11/14/2005	RSD
G01R 31/3177, G01R 31/3181 (foreign documents, see Search History printout)	11/14/2005	RSD
G01R 31/3188 (text search of foreign documents, see Search History printout)	11/14/2005	RSD
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History printout)	11/15/2005	RSD
INSPEC, IEEE Xplore, Google	11/15/2005	RSD
Inventors' name search	11/15/2005	RSD